

## N- and P-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY				
	V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)
N-Channel	20	0.036 at V <sub>GS</sub> = 4.5 V	6.0	5.4 nC
		0.063 at V <sub>GS</sub> = 2.5 V	6.0	
P-Channel	-20	0.064 at V <sub>GS</sub> = -4.5 V	-6.0	6.0 nC
		0.095 at V <sub>GS</sub> = -2.5 V	-6.0	

### FEATURES

- Halogen-free
- TrenchFET<sup>®</sup> Power MOSFETs

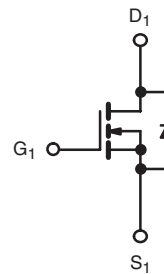
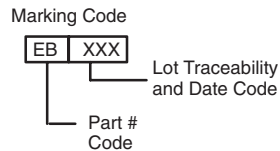
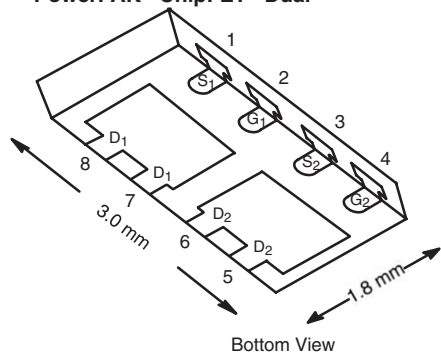


**RoHS**  
COMPLIANT

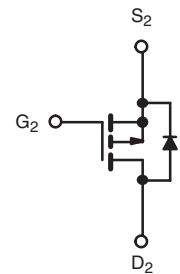
### APPLICATIONS

- Portable DC-DC Applications

PowerPAK<sup>®</sup> ChipFET<sup>®</sup> Dual



N-Channel MOSFET



P-Channel MOSFET

Ordering Information: Si5519DU-T1-GE3 (Lead (Pb)-free and Halogen-free)

ABSOLUTE MAXIMUM RATINGS T <sub>A</sub> = 25 °C, unless otherwise noted					
Parameter	Symbol	N-Channel	P-Channel	Unit	
Drain-Source Voltage	V <sub>DS</sub>	20	-20	V	
Gate-Source Voltage	V <sub>GS</sub>	±12			
Continuous Drain Current (T <sub>J</sub> = 150 °C)	I <sub>D</sub>	T <sub>C</sub> = 25 °C	6.0 <sup>a</sup>	-6.0 <sup>a</sup>	A
		T <sub>C</sub> = 70 °C	6.0 <sup>a</sup>	-6.0 <sup>a</sup>	
		T <sub>A</sub> = 25 °C	6.0 <sup>a, b, c</sup>	-4.8 <sup>b, c</sup>	
		T <sub>A</sub> = 70 °C	4.9 <sup>b, c</sup>	-3.8 <sup>b, c</sup>	
Pulsed Drain Current	I <sub>DM</sub>	25	-20		
Source Drain Current Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	6.0 <sup>a</sup>	-6.0 <sup>a</sup>	
		T <sub>A</sub> = 25 °C	1.9 <sup>b, c</sup>	-1.9 <sup>b, c</sup>	
Maximum Power Dissipation	P <sub>D</sub>	T <sub>C</sub> = 25 °C	10.4	10.4	W
		T <sub>C</sub> = 70 °C	6.6	6.6	
		T <sub>A</sub> = 25 °C	2.27 <sup>b, c</sup>	2.27 <sup>b, c</sup>	
		T <sub>A</sub> = 70 °C	1.45 <sup>b, c</sup>	1.45 <sup>b, c</sup>	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150		°C	
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>		260			

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	N-Channel		P-Channel		Unit
			Typ.	Max.	Typ.	Max.	
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 5 s	R <sub>thJA</sub>	43	55	43	55	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	9.5	12	9.5	12	

Notes:

- Package limited.
- Surface Mounted on 1" x 1" FR4 board.
- t = 5 s.
- See Reliability Manual for profile. The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- Maximum under Steady State conditions is 105 °C/W.

SPECIFICATIONS $T_J = 25^\circ\text{C}$ , unless otherwise noted								
Parameter	Symbol	Test Conditions		Min.	Typ. <sup>a</sup>	Max.	Unit	
<b>Static</b>								
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$	N-Ch	20			V	
		$V_{GS} = 0\text{ V}, I_D = -250\ \mu\text{A}$	P-Ch	-20				
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = 250\ \mu\text{A}$	N-Ch		20.74		mV/ $^\circ\text{C}$	
		$I_D = -250\ \mu\text{A}$	P-Ch		-18.2			
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250\ \mu\text{A}$	N-Ch		4.0			
		$I_D = -250\ \mu\text{A}$	P-Ch		1.83			
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$	N-Ch	0.6		1.8	V	
		$V_{DS} = V_{GS}, I_D = -250\ \mu\text{A}$	P-Ch	-0.6		-1.8		
Gate-Body Leakage	$I_{GSS}$	$V_{DS} = 0\text{ V}, V_{GS} = \pm 12\text{ V}$	N-Ch			100	nA	
			P-Ch			-100		
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}$	N-Ch			1	$\mu\text{A}$	
			P-Ch			-1		
		$V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}, T_J = 55^\circ\text{C}$	N-Ch			10		
			P-Ch			-10		
On-State Drain Current <sup>b</sup>	$I_{D(on)}$	$V_{DS} \leq 5\text{ V}, V_{GS} = 4.5\text{ V}$	N-Ch	25			A	
		$V_{DS} \leq -5\text{ V}, V_{GS} = -4.5\text{ V}$	P-Ch	-10				
Drain-Source On-State Resistance <sup>b</sup>	$R_{DS(on)}$	$V_{GS} = 4.5\text{ V}, I_D = 6.1\text{ A}$	N-Ch		0.030	0.036	$\Omega$	
		$V_{GS} = -4.5\text{ V}, I_D = -4.8\text{ A}$	P-Ch		0.053	0.064		
		$V_{GS} = 2.5\text{ V}, I_D = 1.6\text{ A}$	N-Ch		0.052	0.063		
		$V_{GS} = -2.5\text{ V}, I_D = -1.05\text{ A}$	P-Ch		0.078	0.095		
Forward Transconductance <sup>b</sup>	$g_{fs}$	$V_{DS} = 10\text{ V}, I_D = 6.7\text{ A}$	N-Ch		15		S	
		$V_{DS} = -10\text{ V}, I_D = -4.8\text{ A}$	P-Ch		9.5			
<b>Dynamic<sup>a</sup></b>								
Input Capacitance	$C_{iss}$	N-Channel $V_{DS} = 10\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	N-Ch		660		pF	
			P-Ch		475			
Output Capacitance	$C_{oss}$		P-Channel $V_{DS} = -10\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	N-Ch		108		
				P-Ch		135		
Reverse Transfer Capacitance	$C_{rss}$			N-Ch		65		
				P-Ch		100		
Total Gate Charge	$Q_g$		$V_{DS} = 10\text{ V}, V_{GS} = 10\text{ V}, I_D = 4.8\text{ A}$	N-Ch		11.65	17.5	nC
				P-Ch		11.7	18	
		$V_{DS} = 10\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 4.8\text{ A}$	N-Ch		5.4	8.1		
			P-Ch		6.0	9.0		
Gate-Source Charge	$Q_{gs}$	$V_{DS} = -10\text{ V}, V_{GS} = -4.5\text{ V}, I_D = -3.2\text{ A}$	N-Ch		1.48			
Gate-Drain Charge	$Q_{gd}$		P-Ch		1.05			
			N-Ch		1.4			
			P-Ch		2.1			
Gate Resistance	$R_g$	$f = 1\text{ MHz}$	N-Ch		5.2		$\Omega$	
			P-Ch		9.8			



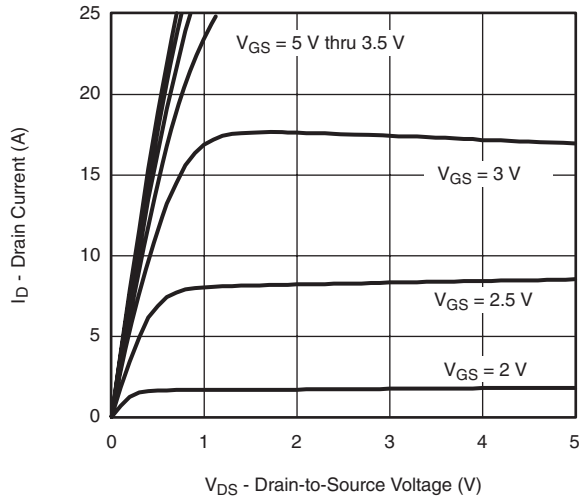
<b>SPECIFICATIONS</b> $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted							
Parameter	Symbol	Test Conditions	Min.	Typ. <sup>a</sup>	Max.	Unit	
<b>Dynamic<sup>a</sup></b>							
Turn-On Delay Time	$t_{d(on)}$	N-Channel $V_{DD} = 10\text{ V}$ , $R_L = 2.04\ \Omega$ $I_D \cong 4.9\text{ A}$ , $V_{GEN} = 4.5\text{ V}$ , $R_g = 1\ \Omega$	N-Ch		5.5	8.25	ns
			P-Ch		4.5	6.8	
Rise Time	$t_r$		N-Ch		15	22.5	
			P-Ch		11	16.5	
Turn-Off Delay Time	$t_{d(off)}$	P-Channel $V_{DD} = -10\text{ V}$ , $R_L = 2.63\ \Omega$ $I_D \cong -3.8\text{ A}$ , $V_{GEN} = -4.5\text{ V}$ , $R_g = 1\ \Omega$	N-Ch		22	33	
			P-Ch		25	37.5	
Fall Time	$t_f$		N-Ch		6	9	
			P-Ch		8.5	12.8	
<b>Drain-Source Body Diode Characteristics</b>							
Continuous Source-Drain Diode Current	$I_S$	$T_C = 25\text{ }^\circ\text{C}$	N-Ch			8.6	A
			P-Ch			- 8.6	
Pulse Diode Forward Current <sup>a</sup>	$I_{SM}$		N-Ch			25	A
			P-Ch			- 20	
Body Diode Voltage	$V_{SD}$	$I_S = 3.1\text{ A}$ , $V_{GS} = 0\text{ V}$	N-Ch		0.8	1.2	V
		$I_S = -2.2\text{ A}$ , $V_{GS} = 0\text{ V}$	P-Ch		- 0.8	- 1.2	
Body Diode Reverse Recovery Time	$t_{rr}$	N-Channel $I_F = 3.1\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$ , $T_J = 25\text{ }^\circ\text{C}$	N-Ch		14.4	21.6	ns
			P-Ch		20.6	31	
Body Diode Reverse Recovery Charge	$Q_{rr}$	P-Channel $I_F = -2.2\text{ A}$ , $di/dt = -100\text{ A}/\mu\text{s}$ , $T_J = 25\text{ }^\circ\text{C}$	N-Ch		8	12	nC
			P-Ch		7.2	11	
Reverse Recovery Fall Time	$t_a$		N-Ch		10		ns
			P-Ch		6.6		
Reverse Recovery Rise Time	$t_b$		N-Ch		4.4		
			P-Ch		14		

Notes:

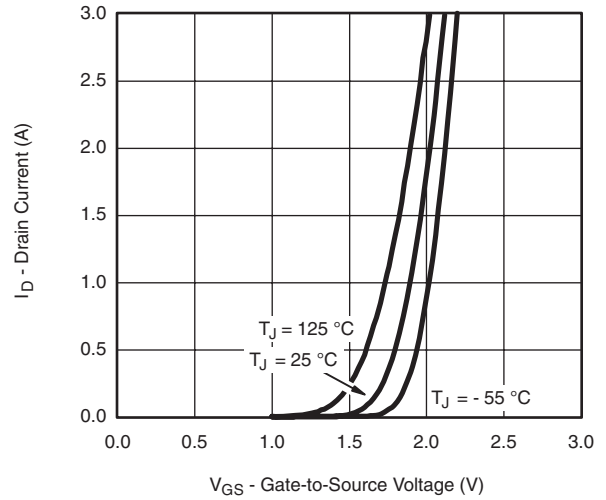
- a. Guaranteed by design, not subject to production testing.
- b. Pulse test; pulse width  $\leq 300\ \mu\text{s}$ , duty cycle  $\leq 2\%$ .

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

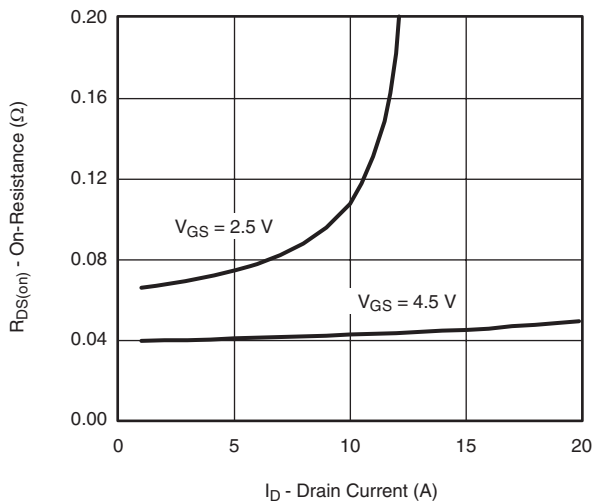
## N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



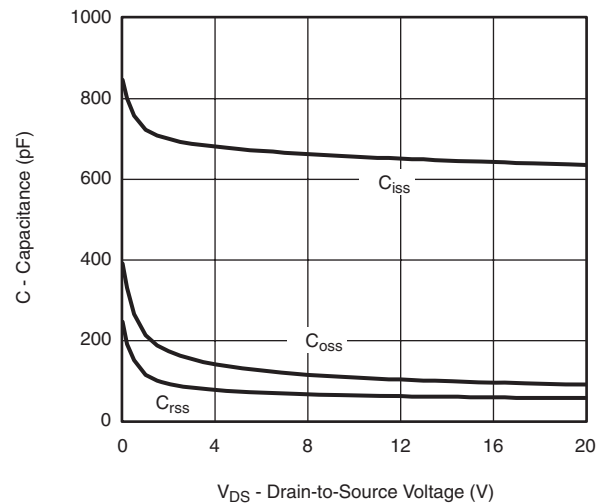
**Output Characteristics**



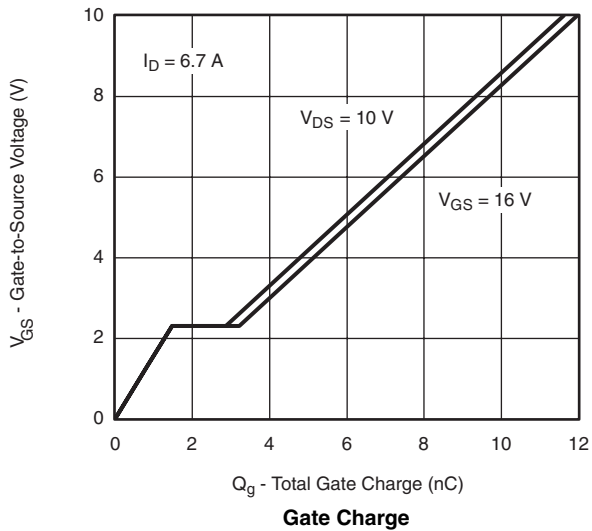
**Transfer Characteristics**



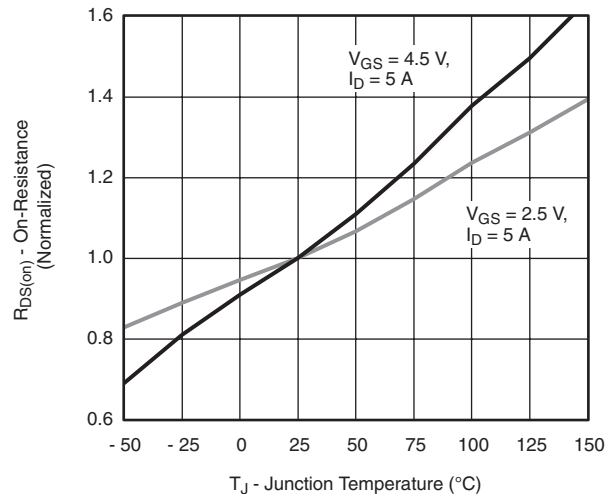
**On-Resistance vs. Drain Current and Gate Voltage**



**Capacitance**

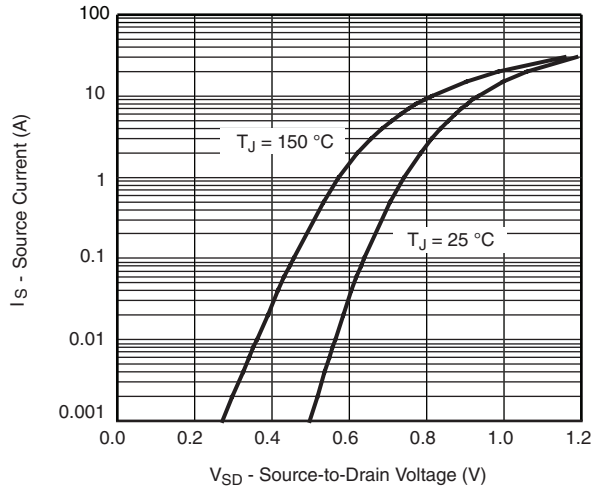


**Gate Charge**

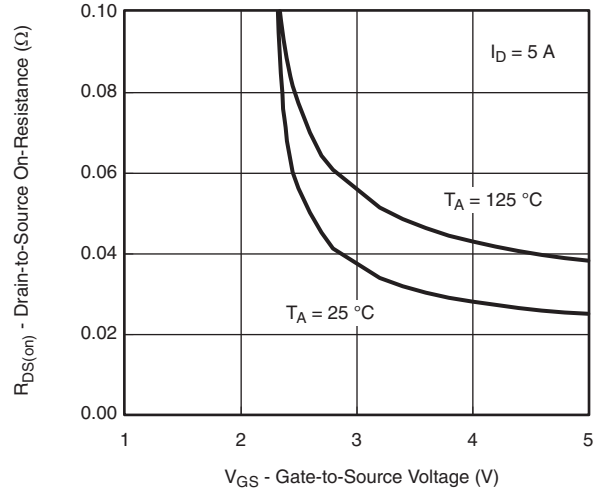


**On-Resistance vs. Junction Temperature**

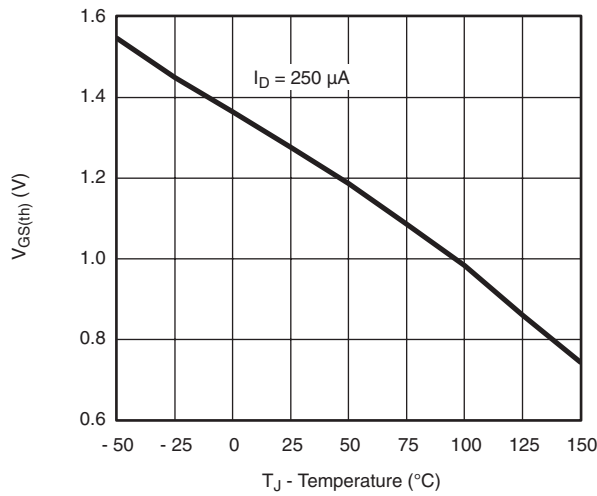
**N-CHANNEL TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted



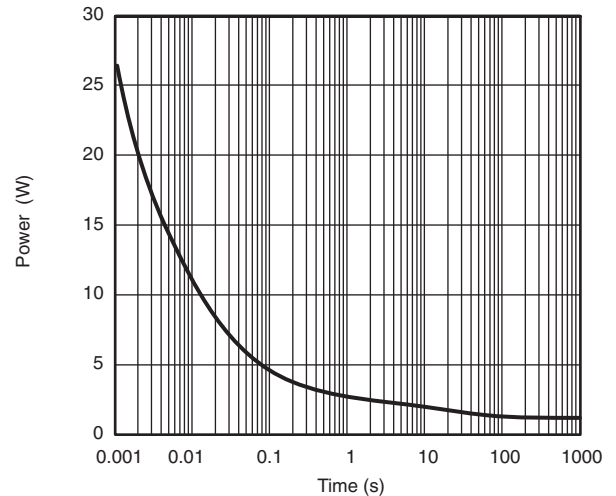
**Source-Drain Diode Forward Voltage**



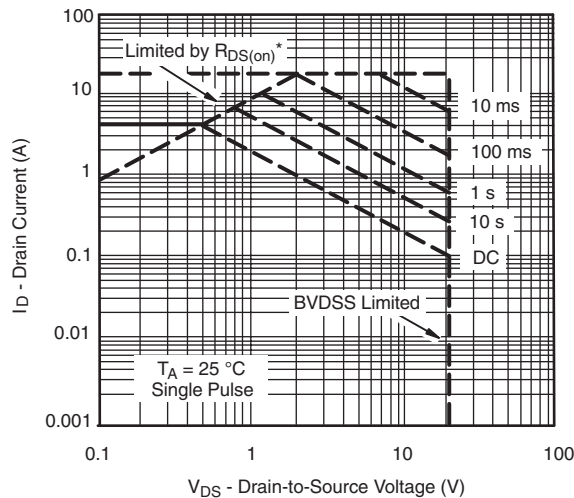
**On-Resistance vs. Gate-to-Source Voltage**



**Threshold Voltage**



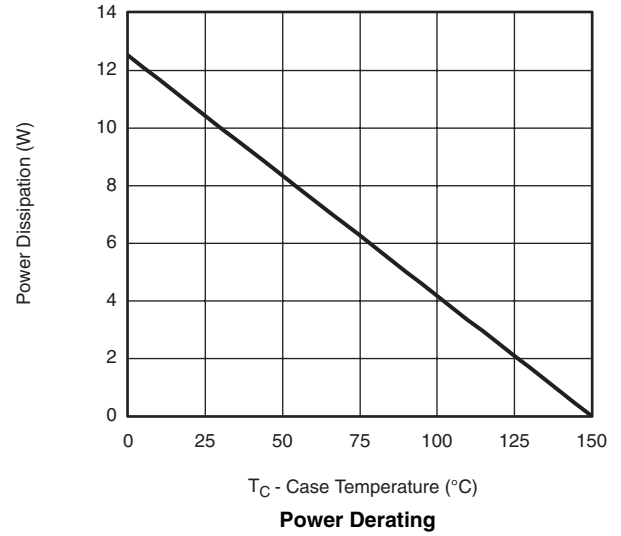
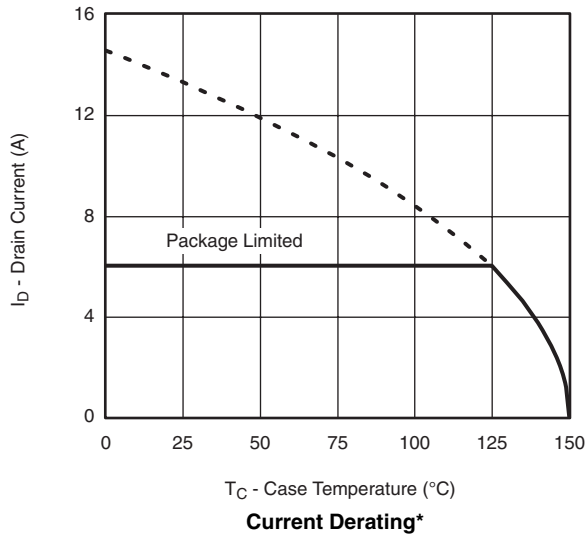
**Single Pulse Power**



\*  $V_{GS} >$  minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

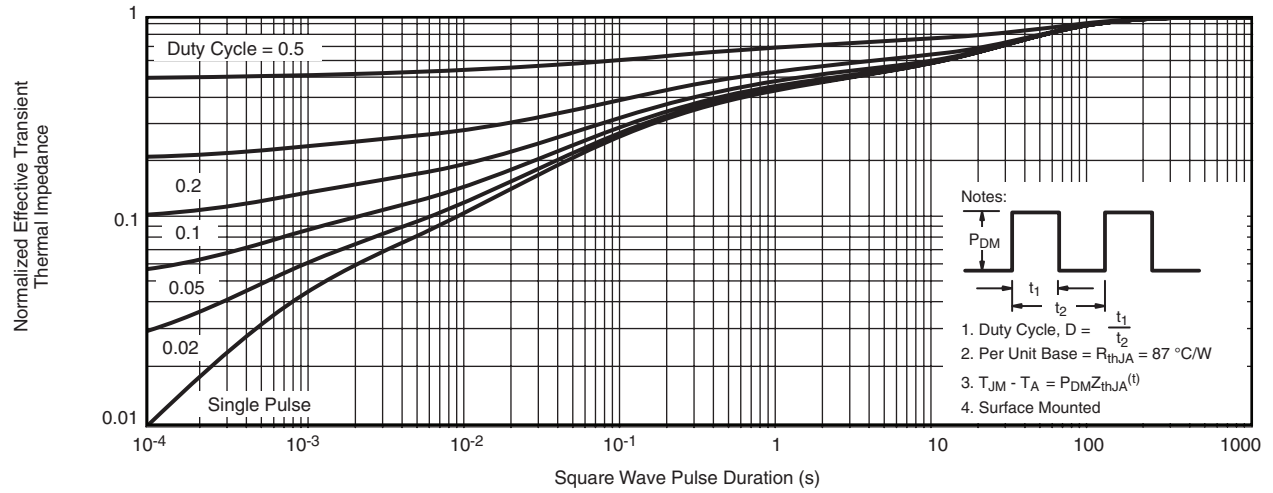
**Safe Operating Area, Junction-to-Ambient**

## N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

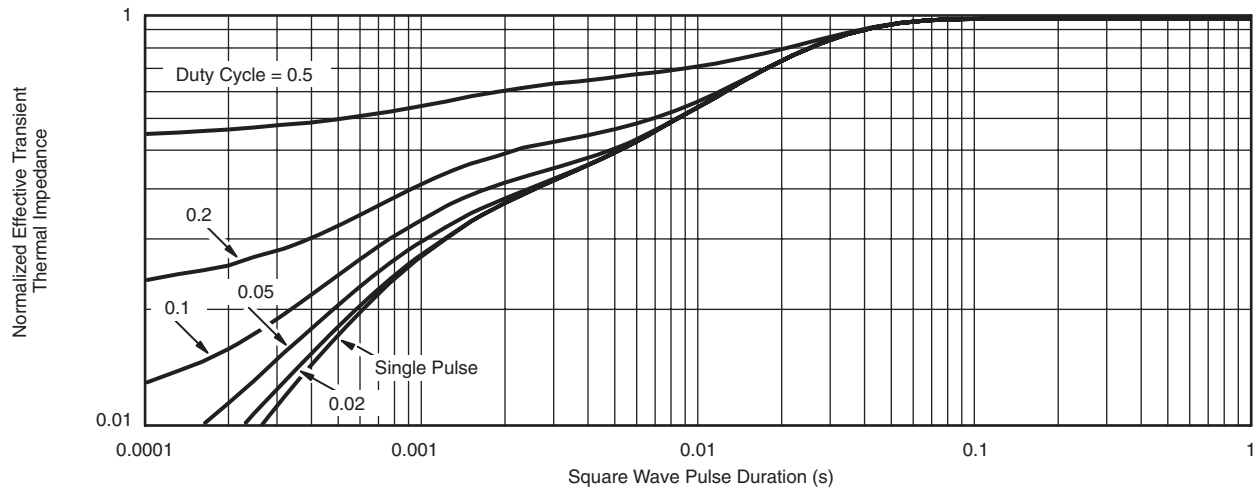


\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 150\text{ °C}$ , using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

**N-CHANNEL TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

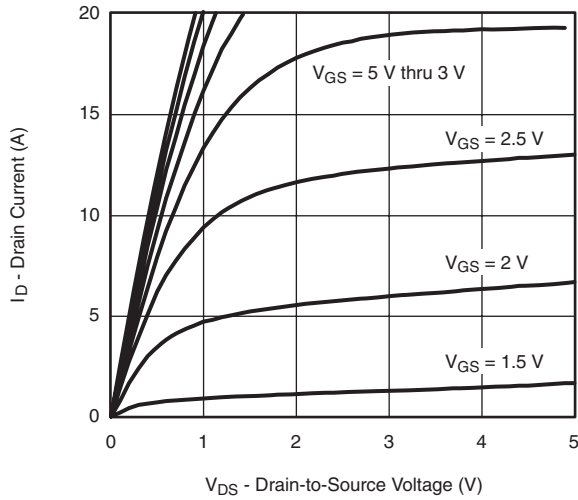


**Normalized Thermal Transient Impedance, Junction-to-Ambient**

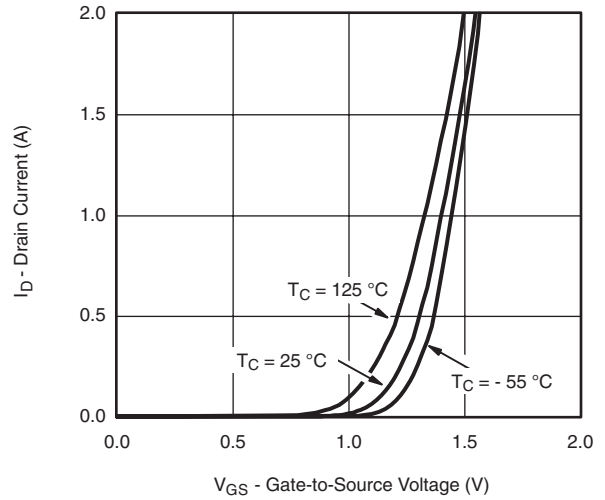


**Normalized Thermal Transient Impedance, Junction-to-Case**

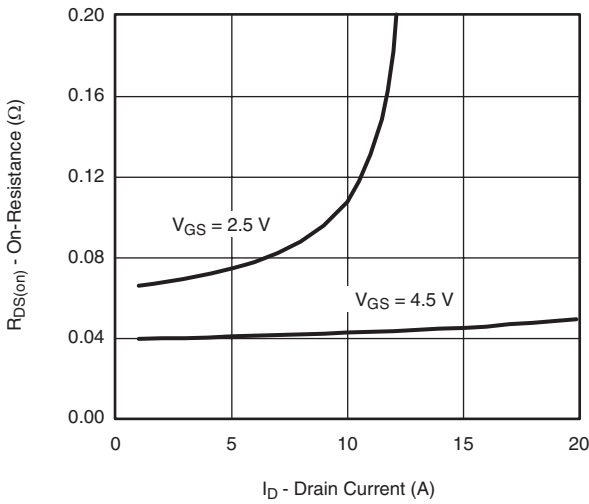
## P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



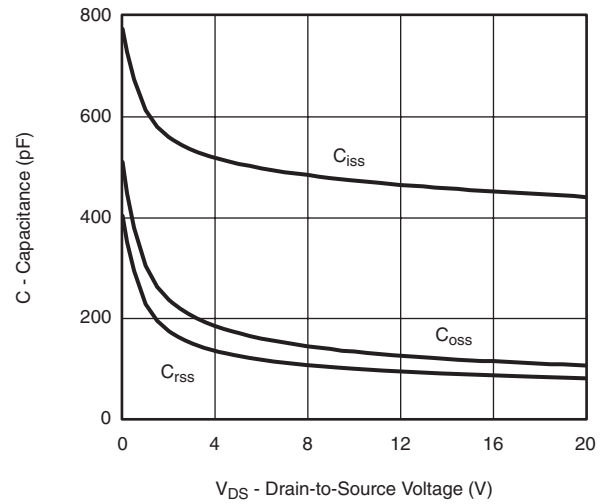
**Output Characteristics**



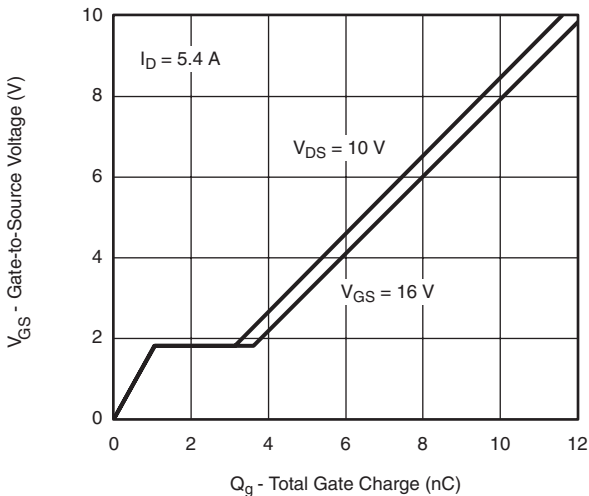
**Transfer Characteristics**



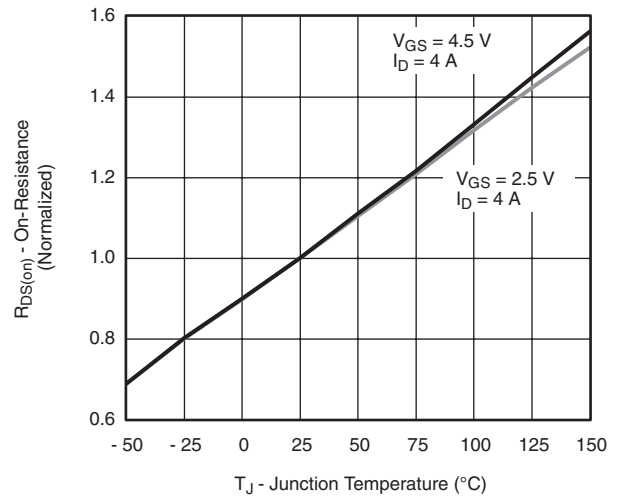
**On-Resistance vs. Drain Current and Gate Voltage**



**Capacitance**



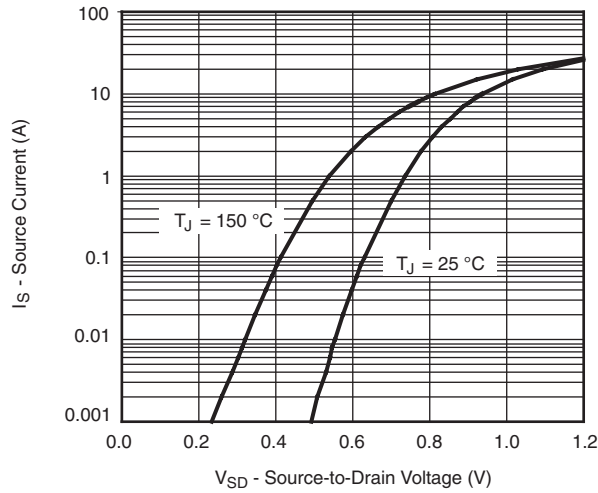
**Gate Charge**



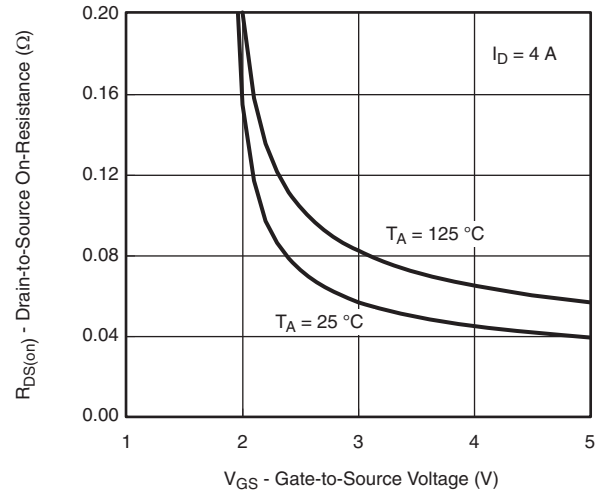
**On-Resistance vs. Junction Temperature**



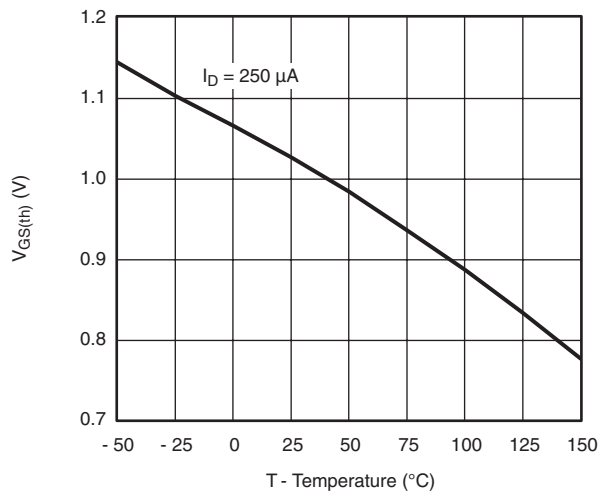
**P-CHANNEL TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted



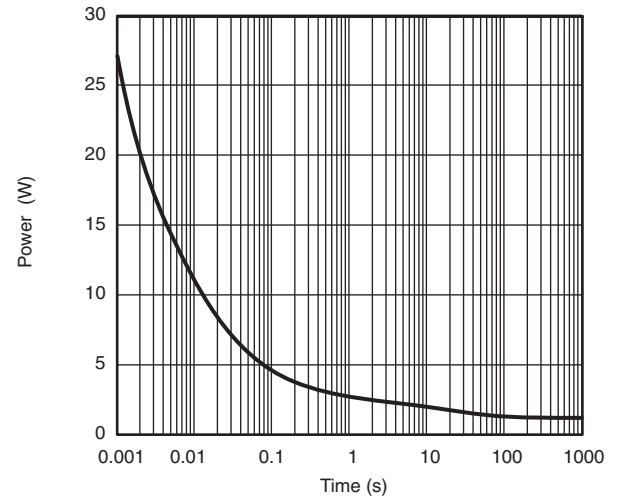
**Source-Drain Diode Forward Voltage**



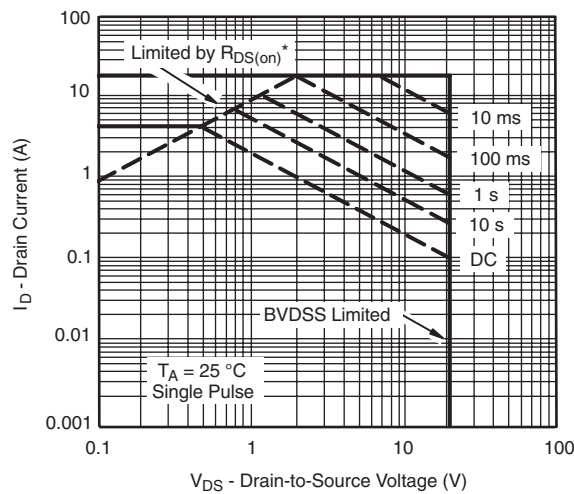
**On-Resistance vs. Gate-to-Source Voltage**



**Threshold Voltage**



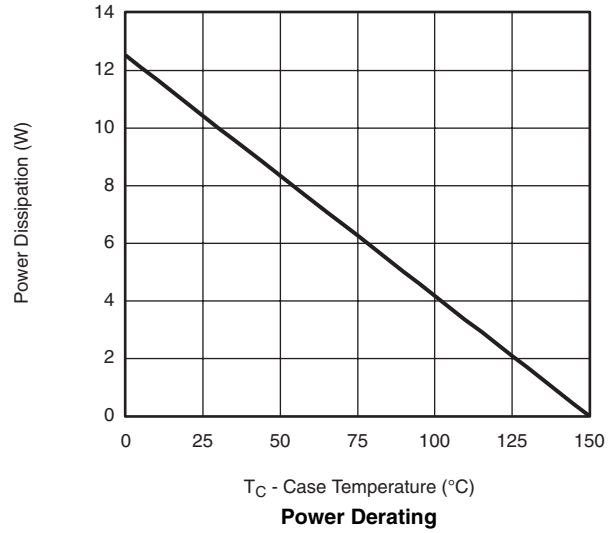
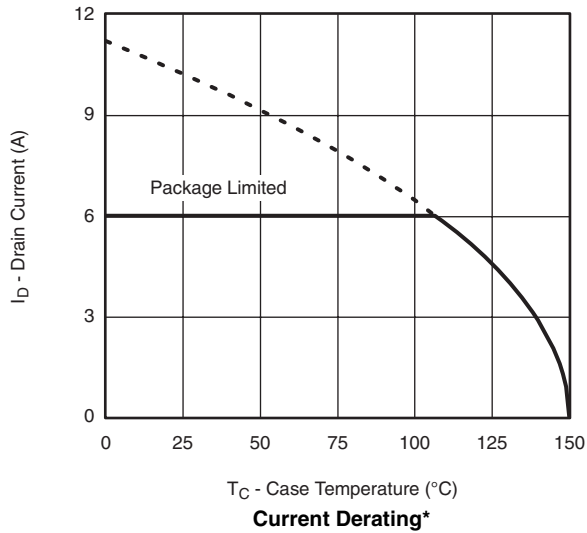
**Single Pulse Power**



\*  $V_{GS} >$  minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

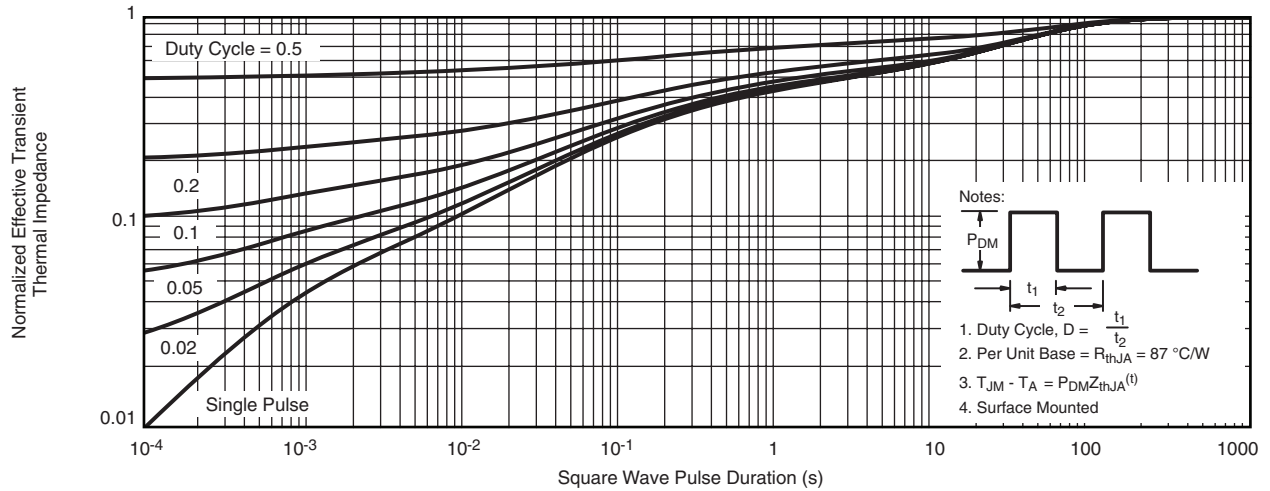
**Safe Operating Area, Junction-to-Case**

**P-CHANNEL TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

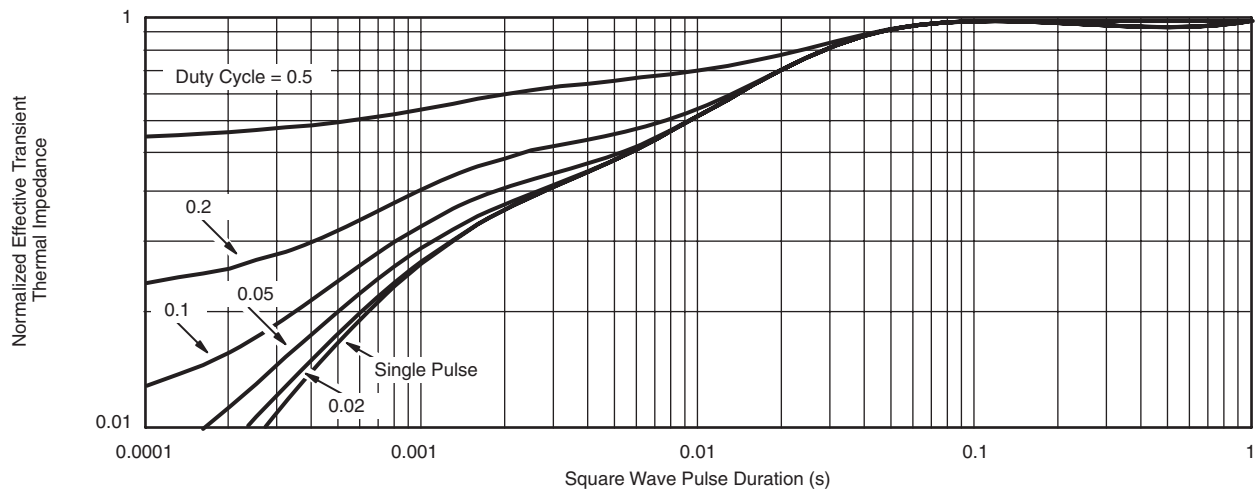


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**P-CHANNEL TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted



**Normalized Thermal Transient Impedance, Junction-to-Ambient**



**Normalized Thermal Transient Impedance, Junction-to-Case**

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